

FDP2670/FDB2670

200V N-Channel PowerTrench[®] MOSFET

General Description

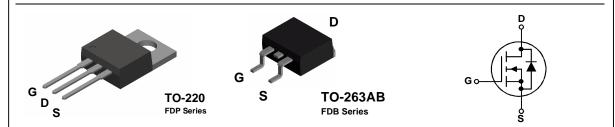
This N-Channel MOSFET has been designed specifically for switching on the primary side in the isolated DC/DC converter application. Any application requiring a 200V MOSFETs with low on-resistance and fast switching will benefit.

These MOSFETs feature faster switching and lower gate charge than other MOSFETs with comparable $\mathsf{RDS}_{(\mathsf{ON})}$ specifications.

The result is a MOSFET that is easy and safer to drive (even at very high frequencies), and DC/DC power supply designs with higher overall efficiency.

Features

- 19 A, 200 V. $R_{\text{DS(ON)}}$ = 130 m Ω @ V_{GS} = 10 V
- Low gate charge (27 nC typical)
- Fast switching speed
- + High performance trench technology for extremely low $R_{\text{DS}(\text{ON})}$
- High power and current handling capability



Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		200	V
V _{GSS}	Gate-Source Voltage		± 20	V
ID	Drain Current – Continuous	(Note 1)	19	А
	– Pulsed	(Note 1)	40	A
PD	Total Power Dissipation @ T _c = 25°C	;	93	W
	Derate above 25°C		0.63	W°/C
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	3.2	V/ns
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-65 to +175	°C

Thermal Characteristics

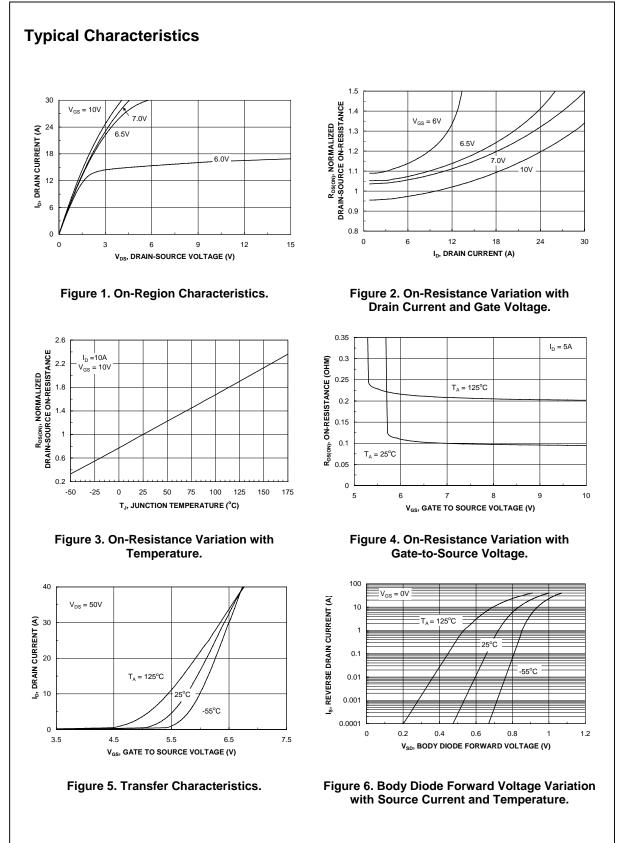
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	1.6	°C/W
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction-to-Ambient	62.5	°C/W

Package Marking and Ordering Information

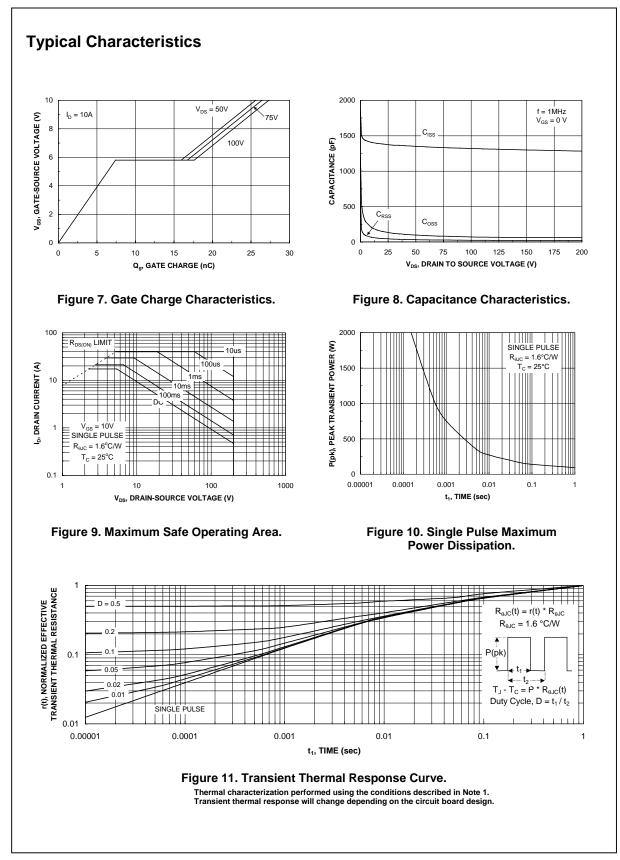
Device Marking	Device	Reel Size	Tape width	Quantity	
FDB2670	FDB2670	13"	24mm	800 units	
FDP2670	FDP2670	Tube	n/a	45 units	

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Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Drain-So	burce Avalanche Ratings (Note					
N _{DSS}	Single Pulse Drain-Source Avalanche Energy	$V_{DD} = 100 \text{ V}, \qquad I_D = 10 \text{ A}$			375	mJ
AR	Maximum Drain-Source Avalanche Current				10	А
Off Char	acteristics	1				
3V _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 V, I_{D} = 250 \mu A$	200			V
Δ <u>BVdss</u> ΔTj	Breakdown Voltage Temperature Coefficient	$I_D = 250 \mu\text{A}$, Referenced to 25°C		241		mV/°C
DSS	Zero Gate Voltage Drain Current	$V_{DS} = 160 \text{ V}, V_{GS} = 0 \text{ V}$			1	μA
GSSF	Gate-Body Leakage, Forward	$V_{GS} = 20 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
GSSR	Gate-Body Leakage, Reverse	$V_{GS} = -20 \text{ V} \qquad V_{DS} = 0 \text{ V}$			-100	nA
On Char	acteristics (Note 2)	•				
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$	2	4	4.5	V
$\Delta V_{GS(th)}$ ΔT_J	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \mu$ A, Referenced to 25°C		-9		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance	$V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$ $V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}, T_J = 125^{\circ}\text{C}$		98 205	130 285	mΩ
D(on)	On–State Drain Current	$V_{GS} = 10 \text{ V}, V_{DS} = 10 \text{ V}$	20			А
g Fs	Forward Transconductance	$V_{\rm DS} = 10 \text{ V}, \qquad I_{\rm D} = 10 \text{ A}$	-	24		S
-	Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = 100 V$, $V_{GS} = 0 V$,	1	1320		pF
Coss	Output Capacitance	f = 1.0 MHz	1	71		pF
Crss	Reverse Transfer Capacitance	1		24		pF
	·					P .
	g Characteristics (Note 2)	V 400 V 1 4 4	1	14	25	20
d(on)	Turn–On Delay Time Turn–On Rise Time			5	10	ns
r		$V_{\rm GS} = 10^{\circ}$, $V_{\rm GEN} = 0.22$		26	41	ns
d(off)	Turn–Off Delay Time Turn–Off Fall Time	-		-		ns
f				23	37	ns
ב ל ^מ	Total Gate Charge	$V_{DS} = 100 \text{ V}, \qquad I_D = 10 \text{ A}, V_{GS} = 10 \text{ V}$		27 7	38	nC
כ ^{gs}	Gate-Source Charge					nC
	Gate-Drain Charge			10		nC
	ource Diode Characteristics		1	1	40	•
S	Maximum Continuous Drain–Source Drain–Source Diode Forward	Diode Forward Current			19	A
V _{SD}	Voltage	$V_{GS} = 0 V$, $I_{S} = 10 A$ (Note 2)		0.8	1.3	V
Pulse Test: Pu	ntinuous current based on maximum allowable jun Ilse Width < 300μs, Duty Cycle < 2.0% ≤ 100A/μs, V _{DD} ≤ BV _{DSS} , Starting T _J = 25°C	ction temperature.				



FDP2670/FDB2670 Rev C1(W)



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